

INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)		ATTY. DOCKET NO. 50212-509		SERIAL NO. 			
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U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ₂ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
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FOREIGN PATENT DOCUMENTS							
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mqd		FLUDGER, et al. "Electrical Measurements of Multipath Interference in Distributed Raman Amplifiers" Journal of Lightwave Technology Vol. 19, No. 4 (April, 2001) pp. 536-545.					
mqd		LEWIS, et al. "Characterization of Double Rayleigh Scatter Noise in Raman Amplifiers" IEEE Photonic Technology Letters Vol. 12, No. 5 (May, 2000) pp. 528-530.					
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Mark Hellner		6/17/2005					

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